## Supporting Information: Two-dimensional Ferroelectric MoS<sub>2</sub>/Ga<sub>2</sub>O<sub>3</sub> Heterogeneous Bilayers with Highly Tunable Photocatalytic and Electrical Properties

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## Extended Computational data



## Searching of Stable Stacking Configurations

Fig. S1 Schematic views of relaxed  $MoS_2/Ga_2O_3^{\uparrow}$  heterostructures with various highsymmetry atomic arrangements. (a) to (f) are labeled as Type-I to Type-VI, respectively.

Heterostructure	Energy Difference (meV per unit cell)
Type-I	6.55
Type-II	61.07
Type-III	0
Type-IV	60.44
Type-V	5.93
Type-VI	2.78

Table S1: Energy difference of  $MoS_2/Ga_2O_3\uparrow$ 



Fig. S2 Schematic views of relaxed  $MoS_2/Ga_2O_3\downarrow$  heterostructures with various high-symmetry atomic arrangements. (a) to (f) are labeled as Type-I to Type-VI, respectively.

Heterostructure	Energy Difference (meV per unit cell)
Type-I	64.27
Type-II	1.81
Type-III	4.04
Type-IV	5.39
Type-V	64.20
Type-VI	0

Table S2: Energy difference of  $\rm MoS_2/Ga_2O_3{\downarrow}$ 

![](_page_3_Figure_0.jpeg)

Fig. S3 Evolution of temperature (red, left axis) and total energy (blue, right axis) with time during AIMD simulations for (a, d)  $MoS_2/Ga_2O_3\uparrow$  and (g, j)  $MoS_2/Ga_2O_3\downarrow$  heterostructures under relaxed station and 6% tensile strain, respectively. Atomic structures of the heterostructures after (b,e,h,k) 5 ps AIMD simulations at 300 K and further (c,f,i,l) geometry relaxations, respectively.

![](_page_4_Figure_0.jpeg)

Fig. S4 Projected band structure of  $MoS_2/Ga_2O_3^{\uparrow}$  heterostructure for orbitals of (a) Ga (b) Ga-s, Ga-p, Ga-d (c) Ga-s, Ga- $p_x$ , Ga- $p_y$ , Ga- $p_z$  (d) O (e) O-s, O-p (f) O-s, O- $p_x$ , O- $p_y$ , O- $p_z$  (g) Mo (h) Mo-s, Mo-p, Mo-d (i) Mo- $d_{xy}$ , Mo- $d_{yz}$ , Mo- $d_{zz}$ , Mo- $d_{z^2}$ , Mo- $d_{x^2-y^2}$  (j) S (k) S-s, S-p (l) S-s, S- $p_x$ , S- $p_y$ , S- $p_z$ , respectively.

![](_page_5_Figure_0.jpeg)

Fig. S5 Projected band structure of  $MoS_2/Ga_2O_3\downarrow$  heterostructure for orbitals of (a) Ga (b) Ga-s, Ga-p, Ga-d (c) Ga-s, Ga- $p_x$ , Ga- $p_y$ , Ga- $p_z$  (d) O (e) O-s, O-p (f) O-s, O- $p_x$ , O- $p_y$ , O- $p_z$  (g) Mo (h) Mo-s, Mo-p, Mo-d (i) Mo- $d_{xy}$ , Mo- $d_{yz}$ , Mo- $d_{zz}$ , Mo- $d_{z^2}$ , Mo- $d_{x^2-y^2}$  (j) S (k) S-s, S-p (l) S-s, S- $p_x$ , S- $p_y$ , S- $p_z$ , respectively.

![](_page_6_Figure_0.jpeg)

Fig. S6 Partial real-space probability distribution at CBM of (a)  $MoS_2/Ga_2O_3\uparrow$  and (b)  $MoS_2/Ga_2O_3\downarrow$ , with the same isosurface level at  $3.21 \times 10^{-8} e/Bohr^3$ .

![](_page_6_Figure_2.jpeg)

Fig. S7 Transition dipole moment of (a)  $MoS_2/Ga_2O_3\uparrow$  and (b)  $MoS_2/Ga_2O_3\downarrow$  versus biaxial strains.

The squared transition dipole moment  $(P^2)$  between the highest valence band and the lowest conduction band can be used to represent the transition probability of electrons, <sup>S1,S2</sup> as shown in Fig. S7a,b.

For  $MoS_2/Ga_2O_3\uparrow$ , with decreasing compressive strain and increasing tensile strain, the transition probability of electrons tends to increase in the  $\Gamma$  point region. In the highsymmetry K point region, the electron transition probability under tensile strain is much smaller than that of compressive strain. This is because under tensile strain conditions, the conduction band is derived from  $MoS_2$ , while the valance band is occupied by  $Ga_2O_3$ . The electronic transition not only overcomes the band gap but also considers the effect of interlayer transition and intrinsic dipole moment on electrons. It is obvious that  $P^2$  of  $MoS_2/Ga_2O_3\downarrow$  is much higher than  $MoS_2/Ga_2O_3\uparrow$ . What's more, under the tensile strain of 6%, the electron transition with three-times enhancement in  $MoS_2/Ga_2O_3\downarrow$  is observed due to gap narrowing near the  $\Gamma$  region. As a result, the high  $P^2$  and good light absorption show advantages and potentials in solar energy conversion such as photocatalytic water splitting and photodetection.

![](_page_7_Figure_1.jpeg)

Fig. S8 The real-space probability distribution of  $MoS_2/Ga_2O_3\uparrow$  heterostructure along the z direction. The insets show its real-space probability distribution of VBM (K) and CBM (K), respectively, with the same isosurface level at  $3.21 \times 10^{-8} e/Bohr^3$ .

## References

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- (S2) Liao, Y.; Zhang, Z.; Gao, Z.; Qian, Q.; Hua, M. Tunable properties of novel Ga<sub>2</sub>O<sub>3</sub> monolayer for electronic and optoelectronic applications. ACS Appl. Mater. Interfaces 2020, 12, 30659–30669.